

EMI TEST REPORT

Test Report No. 15587018H-B-R1

Customer	TaiyoGikenCo.
Description of EUT	Fully automatic mahjong table
Model Number of EUT	RIICHI-STYLE-HD
FCC ID	2BMR5AMOS001
Test Regulation	FCC Part 15 Subpart B, Class B
Test Result	Complied
Issue Date	April 25, 2025
Remarks	-

Representative test engineerYuichiro Yamazaki
Engineer**Approved by**Shinichi Miyazono
Leader

CERTIFICATE 5107.02

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc.
- ☒ There is no testing item of "Non-accreditation".

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 24.0

ANNOUNCEMENT

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- The results in this report apply only to the sample tested. (Laboratory was not involved in sampling.)
- This sample tested is in compliance with the limits of the above regulation.
- The test results in this test report are traceable to the national or international standards.
- This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
- This test report covers EMC technical requirements. It does not cover administrative issues such as Manual or non-EMC test related Requirements. (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan, Inc. has been accredited.
- The information provided by the customer for this report is identified in SECTION 1.
- The laboratory is not responsible for information provided by the customer which can impact the validity of the results.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No. 15587018H-B

This report is a revised version of 15587018H-B. 15587018H-B is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15587018H-B	January 29, 2025	-
1	15587018H-B-R1	April 25, 2025	Correction of erroneous description for Test Date in Clause 2.1; from December 13 and 19, 2024 to December 19, 2024
1	15587018H-B-R1	April 25, 2025	Correction of the Rating in Clause 2.2; From AC 100 V to 120 V To AC 110 V to 120 V

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	Hori.	Horizontal
AAN	Asymmetric Artificial Network	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	I/O	Input/Output
AE	Auxiliary equipment	IEC	International Electrotechnical Commission
AM	Amplitude Modulation	IEEE	Institute of Electrical and Electronics Engineers
AMN	Artificial Mains Network	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISN	Impedance Stabilization Network
AP	Access Point	ISO	International Organization for Standardization
ASK	Amplitude Shift Keying	JAB	Japan Accreditation Board
Atten., ATT	Attenuator	LAN	Local Area Network
AV	Average	LCL	Longitudinal Conversion Loss
BPSK	Binary Phase-Shift Keying	LIMS	Laboratory Information Management System
BR	Bluetooth Basic Rate	LISN	Line Impedance Stabilization Network
BT	Bluetooth	MRA	Mutual Recognition Arrangement
BT LE	Bluetooth Low Energy	N/A	Not Applicable
BW	BandWidth	NIST	National Institute of Standards and Technology
C.F	Correction Factor	NS	No signal detect.
Cal Int	Calibration Interval	NSA	Normalized Site Attenuation
CAV	CISPR AV	OBW	Occupied BandWidth
CCK	Complementary Code Keying	OFDM	Orthogonal Frequency Division Multiplexing
CDN	Coupling Decoupling Network	PER	Packet Error Rate
Ch., CH	Channel	PK	Peak
CISPR	Comite International Special des Perturbations Radioelectriques	P _{LT}	long-term flicker severity
Corr.	Correction	POHC(A)	Partial Odd Harmonic Current
CPE	Customer premise equipment	Pol., Pola.	Polarization
CW	Continuous Wave	PR-ASK	Phase Reversal ASK
DBPSK	Differential BPSK	P _{ST}	short-term flicker severity
DC	Direct Current	QAM	Quadrature Amplitude Modulation
DET	Detector	QP	Quasi-Peak
D-factor, D.fac.	Distance factor	QPSK	Quadrature Phase Shift Keying
Dmax	maximum absolute voltage change during an observation period	r.m.s., RMS	Root Mean Square
DQPSK	Differential QPSK	RBW	Resolution BandWidth
DSSS	Direct Sequence Spread Spectrum	RE	Radio Equipment
DUT	Device Under Test	REV	Reverse
EDR	Enhanced Data Rate	RF	Radio Frequency
e.i.r.p., EIRP	Equivalent Isotropically Radiated Power	RFID	Radio Frequency Identifier
EM clamp	Electromagnetic clamp	RNSS	Radio Navigation Satellite Service
EMC	ElectroMagnetic Compatibility	RSS	Radio Standards Specifications
EMI	ElectroMagnetic Interference	Rx	Receiving
EMS	ElectroMagnetic Susceptibility	S.fac.	Site factor
EN	European Norm	SINAD	Ratio of (Signal + Noise + Distortion) to (Noise + Distortion)
e.r.p., ERP	Effective Radiated Power	S/N	Signal to Noise ratio
ETSI	European Telecommunications Standards Institute	SA, S/A	Spectrum Analyzer
EU	European Union	SABS	South African Bureau of Standards
EUT	Equipment Under Test	SANS	South African National Standards
Fac.	Factor	SG	Signal Generator
FCC	Federal Communications Commission	SVSWR	Site-Voltage Standing Wave Ratio
FHSS	Frequency Hopping Spread Spectrum	THC(A)	Total Harmonic Current
FM	Frequency Modulation	THD(%)	Total Harmonic Distortion
Freq.	Frequency	TR, T/R	Test Receiver
FSK	Frequency Shift Keying	Tx	Transmitting
Fund	Fundamental	UFA	Uniform field area
FWD	Forward	VBW	Video BandWidth
GFSK	Gaussian Frequency-Shift Keying	Vert.	Vertical
GNSS	Global Navigation Satellite System	WLAN	Wireless LAN
GPS	Global Positioning System	xDSL	Generic term for all types of DSL technology (DSL: Digital Subscriber Line)

CONTENTS	PAGE
SECTION 1: Customer information	5
SECTION 2: Equipment under test (EUT)	5
SECTION 3: Test specification, procedures & results	6
SECTION 4: Operation of EUT during testing	8
SECTION 5: Conducted Emission.....	9
SECTION 6: Radiated Emission	10
APPENDIX 1: Test data	11
Conducted Emission	11
Radiated Emission	12
APPENDIX 2: Test instruments	13
APPENDIX 3: Photographs of test setup.....	14
Conducted Emission	14
Radiated Emission	15

SECTION 1: Customer information

Company Name	TaiyoGikenCo.
Address	90 Wada, Mihama-cho, Hidaka-Gun, Wakayama Pref. 644-0044 Japan
Telephone Number	+81-738-22-6153
Contact Person	Takeshi Tomita

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Description	Fully automatic mahjong table
Model Number	RIICHI-STYLE-HD
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	December 13, 2024
Test Date	December 19, 2024

2.2 Product Description

General Specification

Rating	AC 110 V to 120 V
Clock frequency (ies) in the system	27.12 MHz

Radio Specification

Equipment Type	Transceiver
Frequency of Operation	13.56 MHz
Type of Modulation	ASK

2.3 Variant model(s)

Tested model (RIICHI-STYLE-HD) has a variant model (RIICHI-STYLE-EX).

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	FCC Part 15 Subpart B The latest version on the first day of the testing period
Title	FCC 47CFR Part15 Radio Frequency Device Subpart B Unintentional Radiators

3.2 Procedures and results

Item	Test Procedure	Limits	Worst margin	Result	Remarks
Conducted emission	ANSI C63.4: 2014 + C63.4a: 2017 7. AC power - line conducted emission measurements	Class B	16.17 dB 0.57542 MHz, QP, Phase N	Complied	-
Radiated emission	ANSI C63.4: 2014 + C63.4a: 2017 8. Radiated emission measurements	Class B	1.78 dB 51.108 MHz, Vertical, QP	Complied	*1)
* Note: UL Japan, Inc.'s EMI Work Procedure: Work Instructions-ULID-003591. *1) Measurements were limited up to 1 GHz since the highest frequency of internal source of the EUT is less than 108 MHz.					

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Conducted emission

Item	Frequency range	Unit	Calculated Uncertainty (+/-)
AMN (LISN)	0.15 MHz to 30 MHz	dB	3.3

Radiated emission

Measurement distance	Frequency range	Unit	Calculated Uncertainty (+/-)
3 m	9 kHz to 30 MHz	dB	3.3
10 m		dB	3.1
3 m	30 MHz to 200 MHz	Horizontal	5.0
		Vertical	5.0
	200 MHz to 1000 MHz	Horizontal	5.2
		Vertical	6.2
10 m	30 MHz to 200 MHz	Horizontal	5.5
		Vertical	5.4
	200 MHz to 1000 MHz	Horizontal	5.5
		Vertical	5.5

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 3.0 m for No.1, No.2, No.3, No.4, and No.5 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

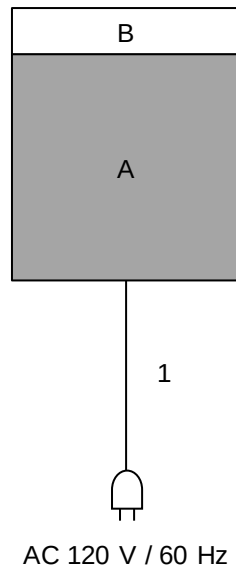
Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Mode	1. Maximum load mode
Software(s)	JP3 MAIN CON VER:1.10

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remarks
A	Fully automatic mahjong table	RIICHI-STYLE-HD	24L0000	TaiyoGikenCo.	EUT
B	Tag	-	-	-	*1)

*1) Tag was installed the predetermined numbers in the prescribed position as one set with 52.

List of Cables Used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	AC Cable	2.5	Unshielded	Unshielded	-

SECTION 5: Conducted Emission

5.1 Operating environment

Date : See data
Test place : See data
Temperature : See data
Humidity : See data
Test engineer : See data

5.2 Test configuration

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT and its peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from the LISN/AMN and excess AC cable was bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN/AMN to the input power source. All unused 50 ohm connectors of the LISN/AMN were resistivity terminated in 50 ohm when not connected to the measuring equipment.

Photographs of the set up are shown in APPENDIX 3.

Frequency range : 0.15 MHz to 30 MHz
EUT position : Table top
EUT operation mode : See Clause 4.1

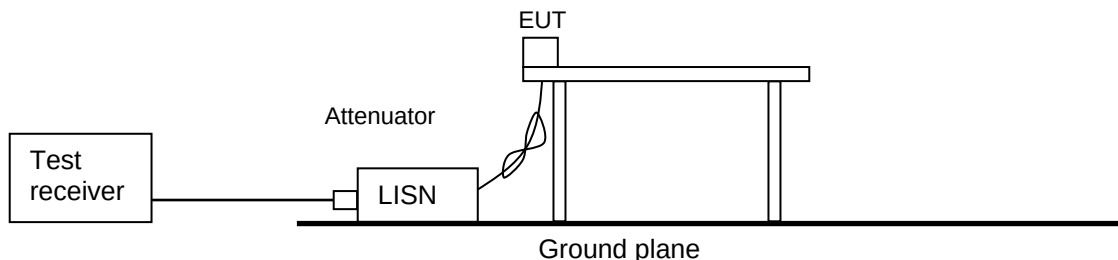
5.3 Test procedure

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT within a semi anechoic chamber. The EUT was connected to a Line Impedance Stabilization Network (LISN)/ Artificial Mains network (AMN). An overview sweep with peak detection has been performed. The measurements have been performed with a quasi-peak detector and if required, with an average detector.

The conducted emission measurements were made with the following detector function of the test receiver.

Detector Type : QP and CAV
IF Bandwidth : 9 kHz

Figure 1: Test Setup



5.4 Test result

Summary of the test results: Pass

The test result is rounded off, so some differences might be observed.

SECTION 6: Radiated Emission

6.1 Operating environment

Date : See data
Test place : See data
Temperature : See data
Humidity : See data
Test engineer : See data

6.2 Test configuration

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.
The EUT was set on the edge of the tabletop.
Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.
Photographs of the set up are shown in APPENDIX 3.

6.3 Test conditions

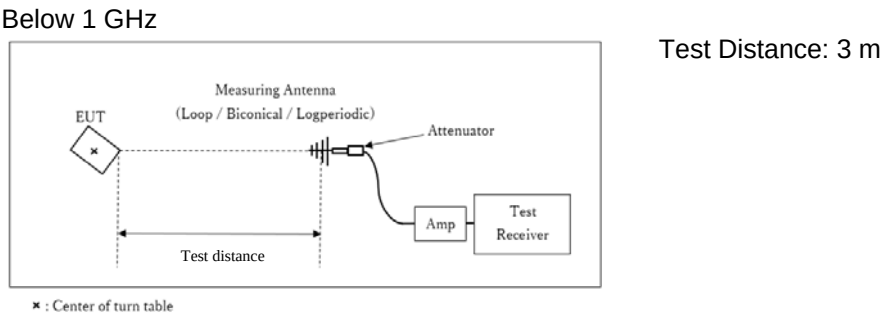
Frequency range : 30 MHz to 200 MHz (Biconical antenna)
200 MHz to 1000 MHz (Logperiodic antenna)
Test distance : 3 m
EUT position : Table top
EUT operation mode : See Clause 4.1

6.4 Test procedure

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.
The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver
The radiated emission measurements were made with the following detector function of the Test Receiver

Frequency	Below 1 GHz
Instrument used	Test Receiver
IF Bandwidth	QP: BW 120 kHz

Figure 2: Test Setup



The test was made on EUT at the normal use position.

6.5 Test result

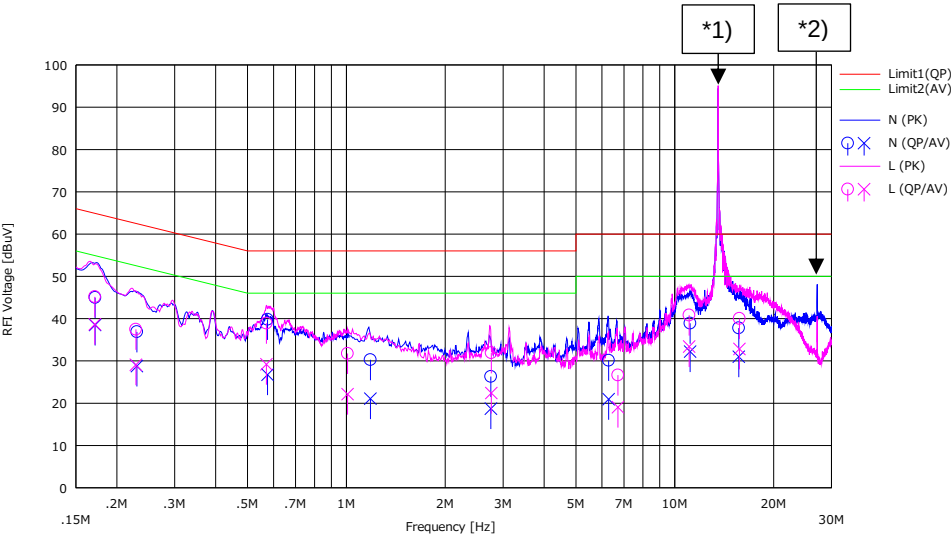
Summary of the test results: Pass
Test results are rounded off and limit are rounded down, so some differences might be observed.

APPENDIX 1: Test data

Conducted Emission

Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date December 19, 2024
Temperature / Humidity 17 deg. C / 37 % RH
Engineer Yuichiro Yamazaki
Mode Mode 1

Limit : FCC_Part 15 Subpart B(15.107)_Class B



No.	Freq.	Reading		USN	LOSS	Results		Limit		Margin		Phase	Comment
		<QP>	<AV>			<QP>	<AV>	<QP>	<AV>	<QP>	<AV>		
	[MHz]	[dBuV]	[dBuV]	[dB]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
1	0.17181	31.80	25.30	0.06	13.12	44.98	38.48	64.87	54.87	19.89	16.39	N	
2	0.23025	23.70	15.60	0.05	13.13	36.88	28.78	62.44	52.44	25.56	23.66	N	
3	0.57542	26.60	13.50	0.06	13.17	39.83	26.73	56.00	46.00	16.17	19.27	N	
4	1.18316	17.00	7.80	0.06	13.21	30.27	21.07	56.00	46.00	25.73	24.93	N	
5	2.75500	12.90	5.30	0.09	13.32	26.31	18.71	56.00	46.00	29.69	27.29	N	
6	6.29290	16.50	7.30	0.16	13.47	30.13	20.93	60.00	50.00	29.87	29.07	N	
7	11.13910	25.00	18.30	0.28	13.62	38.90	32.20	60.00	50.00	21.10	17.80	N	
8	15.66150	23.70	16.90	0.35	13.74	37.79	30.99	60.00	50.00	22.21	19.01	N	
9	0.17146	32.00	25.50	0.04	13.12	45.16	38.66	64.89	54.89	19.73	16.23	L	
10	0.22854	24.30	15.90	0.04	13.13	37.47	29.07	62.50	52.50	25.03	23.43	L	
11	0.57109	25.70	16.00	0.04	13.17	38.91	29.21	56.00	46.00	17.09	16.79	L	
12	1.00790	18.50	8.90	0.05	13.20	31.75	22.15	56.00	46.00	24.25	23.85	L	
13	2.76253	18.50	9.00	0.08	13.32	31.90	22.40	56.00	46.00	24.10	23.60	L	
14	6.71090	13.00	5.40	0.16	13.49	26.65	19.05	60.00	50.00	33.35	30.95	L	
15	11.06080	26.90	19.50	0.28	13.62	40.80	33.40	60.00	50.00	19.20	16.60	L	
16	15.74500	25.90	18.70	0.38	13.74	40.02	32.82	60.00	50.00	19.98	17.18	L	

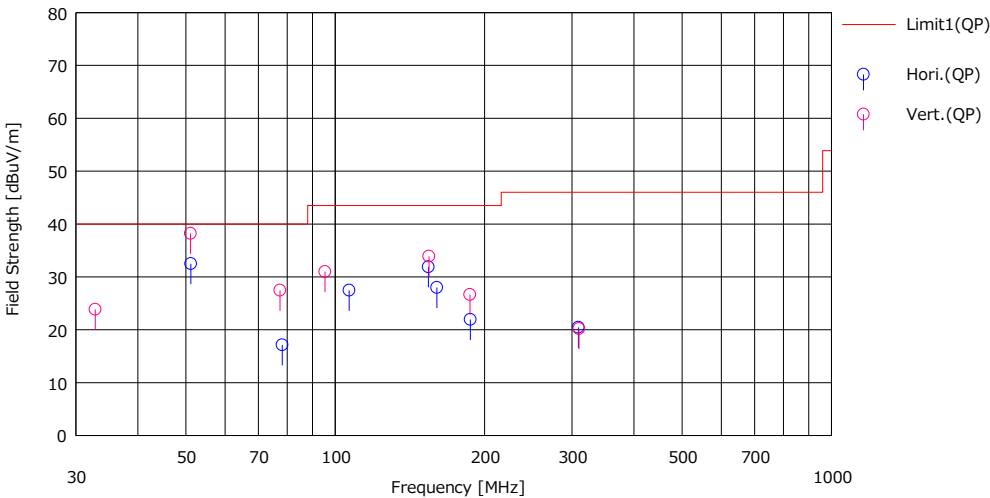
CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + LISN + LOSS (CABLE + ATT)
Except for the above table: adequate margin data below the limits.

*1) 13.56 MHz: RFID Carrier Frequency
*2) 27.12 MHz: RFID 2nd Harmonics

Radiated Emission

Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date December 19, 2024
Temperature / Humidity 17 deg. C / 37 % RH
Engineer Yuichiro Yamazaki
Mode Mode 1

Limit : FCC_Part 15 Subpart B(15.109)_Class B



No.	Freq. [MHz]	Reading (QP)	Ant Foc	Loss	Gain	Result (QP)	Limit (QP)	Margin (QP)	Pola [H/V]	Height [cm]	Angle [deg]	Ant. Type	Comment
		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]					
1	51.167	46.60	10.80	7.29	32.19	32.50	40.00	7.50	Hori.	400	273	BA	
2	78.162	35.00	6.63	7.67	32.17	17.13	40.00	22.87	Hori.	228	326	BA	
3	106.688	40.20	11.41	7.99	32.14	27.46	43.50	16.04	Hori.	292	295	BA	
4	154.119	40.40	15.11	8.48	32.10	31.89	43.50	11.61	Hori.	214	82	BA	
5	160.280	36.10	15.45	8.53	32.09	27.99	43.50	15.51	Hori.	277	312	BA	
6	187.211	28.90	16.34	8.77	32.06	21.95	43.50	21.55	Hori.	234	218	BA	
7	308.953	29.00	13.71	9.74	31.99	20.46	46.00	25.54	Hori.	100	247	LA22	
8	32.842	31.60	17.46	6.99	32.21	23.84	40.00	16.16	Vert.	100	171	BA	
9	51.108	52.30	10.82	7.29	32.19	38.22	40.00	1.78	Vert.	100	290	BA	
10	77.355	45.40	6.57	7.66	32.17	27.46	40.00	12.54	Vert.	100	189	BA	
11	95.364	45.80	9.47	7.87	32.15	30.99	43.50	12.51	Vert.	100	269	BA	
12	154.505	42.40	15.13	8.48	32.10	33.91	43.50	9.59	Vert.	100	296	BA	
13	186.870	33.60	16.34	8.77	32.06	26.65	43.50	16.85	Vert.	100	202	BA	
14	309.827	28.70	13.74	9.75	31.99	20.20	46.00	25.80	Vert.	173	219	LA22	

CHART: WITH FACTOR
ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN
CALCULATION: RESULT = READING + ANT FACTOR + LOSS(CABLE + ATT) - GAIN(AMP)
Except for the above table: adequate margin data below the limits.

APPENDIX 2: Test instruments

Test equipment

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
CE	141216	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM14/ sucoform141-PE/ 421-010/RFM-E321(SW)	-/00640	07/06/2024	12
CE	141248	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	12/03/2024	12
CE	141358	LISN(AMN)	Schwarzbeck Mess-Elektronik OHG	NSLK8127	8127-730	07/09/2024	12
CE	141532	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
CE	141951	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	05/17/2024	12
CE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
CE	142183	Measure	KOMELON	KMC-36	-	10/21/2024	12
CE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
CE	244709	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202103	01/25/2024	12
RE	141266	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	9111B-191	08/23/2024	12
RE	141323	Coaxial cable	UL-ISE	-	-	09/13/2024	12
RE	141424	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHA9103+BBA9106	1915	03/15/2024	12
RE	141532	DIGITAL HiTESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/17/2024	12
RE	141951	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	05/17/2024	12
RE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
RE	142183	Measure	KOMELON	KMC-36	-	10/21/2024	12
RE	142314	Attenuator	Pasternack Enterprises	PE7390-6	D/C 1504	06/06/2024	12
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	244709	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202103	01/25/2024	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

CE: Conducted emission

RE: Radiated emission